

**Notice of References Cited**Application/Control No.  
**09/730,932**Applicant(s)/Patent Under Reexam  
**Rajeev**Examiner  
**Sheila V. Clark**Art Unit  
**2815**

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**U.S. PATENT DOCUMENTS**

	<b>Document Number</b> Country Code-Number-Kind Code	<b>Date</b> MM-YYYY <sup>1</sup>	<b>Name</b>	<b>Classification</b> <sup>2</sup>	
A	6,184,573	2/2001	Pu	----	----
B	5,313,095	5/1994	Tagawa et al	----	----
C	6,316,822	11/2001	Venateshwaran et al	----	----
D	6,313,520	11/2001	Yoshida et al	----	----
E	6,380,615	4/2002	Park et al	----	----
F	63,030,981	10/2001	Moden	----	----
G	6,225,683	5/2001	Yalananchilli et al	----	----
H	6,075,284	6/2000	Choi et al	----	----
I					
J					
K					
L					
M					

**FOREIGN PATENT DOCUMENTS**

	<b>Document Number</b> Country Code-Number-Kind Code	<b>Date</b> MM-YYYY <sup>1</sup>	<b>Country</b>	<b>Name</b>	<b>Classification</b> <sup>2</sup>	
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